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Citation: Applied Physics Letters 97, 262115 (2010); doi: 10.1063/1.3533018
View online: http://dx.doi.org/10.1063/1.3533018
View Table of Contents: http://scitation.aip.org/content/aip/journal/apl/97/26?ver=pdfcov
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Electron-phonon coupling in single-walled carbon nanotubes determined by shot noise

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(Received 29 August 2010; accepted 8 December 2010; published online 29 December 2010)

We have measured shot noise in metallic single-walled carbon nanotubes of length L=1 μm and have found strong suppression of noise with increasing voltage. We conclude that the coupling of electron and phonon baths at temperatures T_e and T_ph is described at intermediate bias (20 mV < V_{ds} ≤ 200 mV) by heat flow equation P=\Sigma L(T_e^2 - T_{ph}^2), where \Sigma \sim 3 \times 10^{-3} W/mK^3 due to electron interaction with acoustic phonons, while at higher voltages optical phonon-electron interaction leads to P=\kappa_{op}[N(T_e) - N(T_{ph})], where N(T)=1/[\exp(\hbar\Omega/k_BT)-1] with optical phonon energy \hbar\Omega and \kappa_{op}=2 \times 10^{2} W/m. © 2010 American Institute of Physics. [doi:10.1063/1.3533018]

Theoretical models based on mean-free path type of arguments have been employed to explain experimental current-voltage characteristics of single-walled carbon nanotubes (SWNTs), and they indicate optical phonon generation with high phonon temperatures in measurements at large bias voltages.1-5 In addition, time-resolved photoelectron spectroscopy has been performed and direct confirmation of the bottleneck and, consequently, shot noise can be employed to obtain information on e-ph coupling.6,7 Recently, high-bias electron transport studies in conjunction with Raman spectroscopy have been performed and direct confirmation of the high phonon temperatures of several hundred kelvins has been obtained.8,9

These investigations have addressed only the phonon temperature and the electronic temperature has not been determined. We have studied shot noise in single-walled nanotubes at high bias and employed the noise to determine the electronic temperature. Assuming that acoustic phonons remain at the substrate temperature, we can determine the relation for the heat flux between electron and phonon baths in SWNTs.10 We compare our results with those obtained by Raman spectroscopy and find close agreement with the reported optical phonon temperatures.

For large electron-phonon (e-ph) or electron-electron scattering rates, the solutions of the diffusive Boltzmann equation tend toward a Fermi function, i.e., to a local equilibrium,11 \[ f(x,v) = f_d(x,v,T(x)) = 1/e^{(eV(x))/T(x)} + 1, \]
characterized by a local potential V(x) and a temperature T(x). Considering a one-dimensional (1D) wire this yields for the Fano factor

\[ \zeta = \frac{S_f}{2eV_{th}} = \frac{2k_BT_e}{LeV} \int_0^L dx \int_{-\infty}^{\infty} df(x,v)[1 - f(x,v)], \]

where S_f denotes the shot noise power and T_e is the average electronic temperature. If thermal conduction is dominated by electronic conduction, the Boltzmann equation yields with the phonon bath at T_{ph}=0: T_e=\sqrt{3}/8eV/k_B and \zeta = \sqrt{3}/4, the well-known theoretical estimate due to hot electrons at an internal equilibrium.12

Besides the electronic heat conduction P_{diff} = \pi^2/3k_B^2N_e(T)\alpha(T)dx/dx, power flow P_{inel} between electrons and phonons has to be taken into account when determining T(x).13 We have considered the standard energy balance model for the electron-sample phonon-substrate coupling described, for example, in Fig. 1 of Ref. 14, in which the Joule heating P_{joule} dissipates either to the diffuse reservoir P_{diff} or to the lattice via inelastic scattering P_{inel}. In such a model, the relative magnitude of P_{diff} to P_{inel} determines the magnitude of the noise: (eV)^2/3k_BT_e^2 = 1/\kappa_{op}, valid in the limit T_{ph}→0; here \kappa_{op} denotes Thouless energy. In Ref. 15 the configuration for a typical nanotube sample is analyzed. Its conclusion is that at intermediate voltages, the electron-phonon heat transfer is the bottleneck and, consequently, shot noise can be employed to obtain information on e-ph coupling.

For the dissipated power P_{inel} via e-ph interaction with Debye-like acoustic phonon spectrum,16 one obtains when Debye temperature \theta_D=\hbar\omega_D/k_BT_e \gg T (see also Ref. 10)

\[ P_{inel} = \Sigma L[T^{e+3} - T^{e+3}_{ph}], \]

where \Sigma specifies the strength of the e-ph interaction per unit length and the exponent \alpha=0 for a 1D sample. In general, \alpha depends on the dimensionality of the electron and phonon systems, disorder, and possibly on other factors.17,18

For a single band of optical phonons with energy \hbar\Omega, P_{inel} is given by

\[ P_{inel} = \kappa_{op}[\coth(h\Omega/2k_BT_e) - \coth(h\Omega/2k_BT_{ph})], \]

where \kappa_{op} describes the strength of the interaction between electrons and phonons via optical phonon modes,19 \kappa_{op} = \kappa_{e-op}\kappa_{op-ac}/(\kappa_{e-op} + \kappa_{op-ac}), where \kappa_{e-op} denotes the coupling between electrons and optical phonons and \kappa_{op-ac} governs the relaxation of optical phonon branches to acoustic phonons.

In voltage-biased nanotubes, the energy of electrons \epsilon is supplied by the voltage V. From the Debye-like acoustic phonon scattering, one obtains \zeta = \sqrt{\pi} \times \epsilon^{-(e+5)/(e+3)}, which yields

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FIG. 1. (Color online) Differential conductance $G_d$ of a typical SWNT nanotube sample recorded at $T=4.2$ K. Measured power spectral density of current noise $S_f(I)$ is shown in the inset.

\[ \tilde{\gamma} \simeq 1/v_{th}^{1/3} \]

for a 1D conductor. For the e-op scattering, the behavior at large voltages can be approximated by the estimate

\[ \tilde{\gamma} = \frac{2(h/\Omega eV)}{\ln[1 + \kappa_{op}/IV]}, \]  

(4)

where we consider e-op coupling as the major relaxation channel.

Our nanotube samples were grown with chemical vapor deposition. They were manufactured on top of insulating sapphire substrates in order to minimize parasitic capacitance and to reduce rf losses. Pairs of 25/15 nm Ti/Au contacts, 0.3 \( \mu \)m apart, were patterned between the catalyst islands by electron beam lithography. A central top-gate, 0.1 \( \mu \)m wide, was deposited between the contacts. It consisted of an insulating barrier, formed by five 2 nm Al layers, each oxidized around 2 nm.

In our measurement setup at frequency $f = 600–950$ MHz, we use a liquid-helium-cooled low-noise amplifier.\textsuperscript{20} We determine the differential Fano factor $F_d$ = $1/2dS_d/dI$ using lock-in techniques and obtain the average, excess noise Fano factor by $F = 1/11[S(\Omega) - S(0)]/(2eI)$.\textsuperscript{21} The non-linearity of the IV curve of the SWNT is taken into account using the scheme described in Ref. 22. Our measured $F$ is an approximation for the true Fano factor $\tilde{\gamma}$ because, with substantial $V_{ds}$-induced sample heating, the noise does not fully cross over to the shot noise regime: the correction factor is at most $\approx \coth 2eV/4k_BT = \coth 1/3 \approx 1$ within 5% when $F < 0.5$, the main region of interest in our analysis.

Figure 1 displays the differential conductance $G_d = dI/dV_{ds}$ versus bias voltage $V_{ds}$ measured at $T=4.2$ K. Initially, there is rather strong Coulomb blockade that suppresses the conductance below a few millivolts. Above the Coulomb blockade $V_{ds} > 10$ mV, $G_d$ increases gradually and reaches a maximum around $V_{ds} = 0.1–0.2$ V, above which $G_d$ starts to decrease, in a manner similar to that found by Yao et al.\textsuperscript{1} As in Ref. 1, we model the decrease by generation of optical phonons. Moreover, this decrease in $G_d$ suggests that the electrical contacts on our sample are reasonably good since otherwise the decrease of conductance due to optical phonon scattering could not be observed according to Ref. 1. Our maximum conductance of $\approx 0.5e^2/h$ (30% less than in Ref. 1) implies a mean-free path of $l_p \approx 60$ nm. There is slight asymmetry in $G_d$ data in Fig. 1, presumably due to universal conductance fluctuation type of behavior.

The results of shot noise measurements $S_f(I)$ are illustrated in the inset of Fig. 1. Using the Khun formula,\textsuperscript{23} we may fit to the data and find $\tilde{\gamma} = 2$ at very small voltage ($V_{ds} < 5$ mV). Large $\tilde{\gamma}$ at low bias is a sign of cotunneling phenomena which are known to enhance shot noise in SWNTs.\textsuperscript{24} At large bias, $V_{ds} > 0.5$ V (above 7 \( \mu \)A in the inset of Fig. 1), $S_f$ tends to saturate, especially at negative bias voltages. This is similar to the behavior observed in semiconducting SWNTs.\textsuperscript{25}

Figure 2 displays the Fano factor $F$ versus $V_{ds}$. Above the cotunneling maximum in $F$ at $V_{ds} \approx 5$ mV (not shown), the Fano factor starts to decrease. The heat transfer is initially dominated by diffusion along the tube and the hot-electron regime is approached. However, the hot-electron value $\tilde{\gamma} = \sqrt{3}/4$ is not favored in Fig. 2. Consequently, we conclude that the noise decreases already at intermediate voltage 20 mV < $V_{ds}$ < 200 mV due to inelastic processes. This finding signifies a relatively large inelastic scattering rate, which may be an indication of coupling to substrate modes.\textsuperscript{26}

At higher bias, power starts to flow out from the electronic system via electron-optical phonon coupling, and $F$ is decreased even stronger. By fitting to the data in Fig. 2 we find that $F \propto V_{ds}^{0.6}$ at $V_{ds} > 100$ mV and $F \propto V_{ds}^{0.45}$ at $V_{ds} < 100$ mV. Other samples yielded similar values at high bias, whereas somewhat larger variation in the exponent was observed at $V_{ds} < 100$ mV. The semiclassical model with acoustic phonon scattering is thus only qualitatively consistent with our data. However, optical phonon scattering described by Eq. (4) is found to agree well with the high-bias data at $V_{ds} \approx 0.2$ V using $\kappa_{op} = 2 \times 10^7$ W/m.

Encouraged by the conformity of semiclassical modeling, we have employed our shot noise results for thermometry to determine the average electronic temperature $T_e$ on the sample according to Eq. (1). Figure 3 displays the total heat flow due to dissipated power $P_{\text{diss}} = IV_{ds}$ vs $T_e$ deduced from $F$. In order to estimate $\Sigma$ and $\kappa_{op}$, we neglect $P_{\text{diss}}$ and consider the contribution of which is small at high bias. A fit using $T_e^* - T_{\text{ph}} = T_{\text{ph}} - T_0$, would work the best over the whole range of data, consistent with an exponent of $\alpha = 1$ in the Debye-like spectrum. This dependence, reminiscent of...
graphenelike two-dimensional behavior,\(^\text{27}\) indicates stronger increase in the number of relaxational channels with energy than expected for a one-dimensional object.

At the intermediate bias range \(20 \text{ mV} < V_{ds} \leq 200 \text{ mV} (T_e = 100 \text{ K})\), we are also able to fit the exponent \(\alpha = 0\) with the data, as seen by the red solid curve in Fig. 3. This yields \(P_{\text{inel}} = \Sigma L (T^3 - T_0^3)\) with \(\Sigma = 3 \times 10^{-9} \text{ W/m K}^3\). At \(V_{ds} \geq 0.2 \text{ V} (T_e \geq 350 \text{ K})\), optical phonons take over and we obtain a good fit of Eq. (3) to the data using \(\kappa_{op} = 2 \times 10^5 \text{ W/m} \) and \(h\Omega = 0.18 \text{ eV}.\(^\text{28}\) Our result displays a different power law compared with the work of Moos et al.\(^\text{7}\) who obtained a relation of \(T^5 - T_0^5\) for a nanotube bundle. Our low-bias dependence \(P \propto T^3\) agrees with the result of Appenzeller et al.\(^\text{29}\) who reported temperature dependence \(\propto 1/T_e\) for the electron-phonon scattering time.

In conclusion, using diffusive transport theory and shot noise measurements in SWNTs at high bias, we determined the electronic temperature that nearly coincides with phonon temperatures obtained recently by Raman spectroscopy in Refs. 9, 26, and 30. Consequently, optical phonons and electrons are nearly at the same temperature, which is in agreement with standard heat flow modeling with typical electron-phonon coupling parameters.\(^\text{4}\)

We wish to thank V. Ermelov, T. Heikilä, F. Mauri, N. Vandecasteele, and J. Viljas for useful discussions and correspondence. This work was supported by the Academy of Finland (Materials World Network), EU Grant No. FP6-IST-021285-2, and the NANOSYSTEMS project with Nokia Research Center.

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